

Search Notes

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10/730,777

Examiner

Jason M. Han

Applicant(s)/Patent under
Reexamination

NISHIZAWA, TAKAAKI

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	462-463	3/22/2005	JMH
362	487	3/22/2005	JMH
362	507	3/22/2005	JMH
362	512, 514	3/22/2005	JMH
362	516	3/22/2005	JMH
362	523	3/22/2005	JMH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search History	3/22/2005	JMH
P.E. Stephen Husar	3/22/2005	JMH